



Express Line TEC Module Tests with ARC

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Overview

- Environment and Test Setup
- Performed tests and most important observations
- Table of results
- Outlook



Express Line TEC Modules

- 2 x 5 TEC Modules received from Karlsruhe

- Bar Codes:

30216630200012

30216630200017

30216630200020

30216630200022

30216630200023

30216630200026

30216630200027

30216630200029

30216630200048

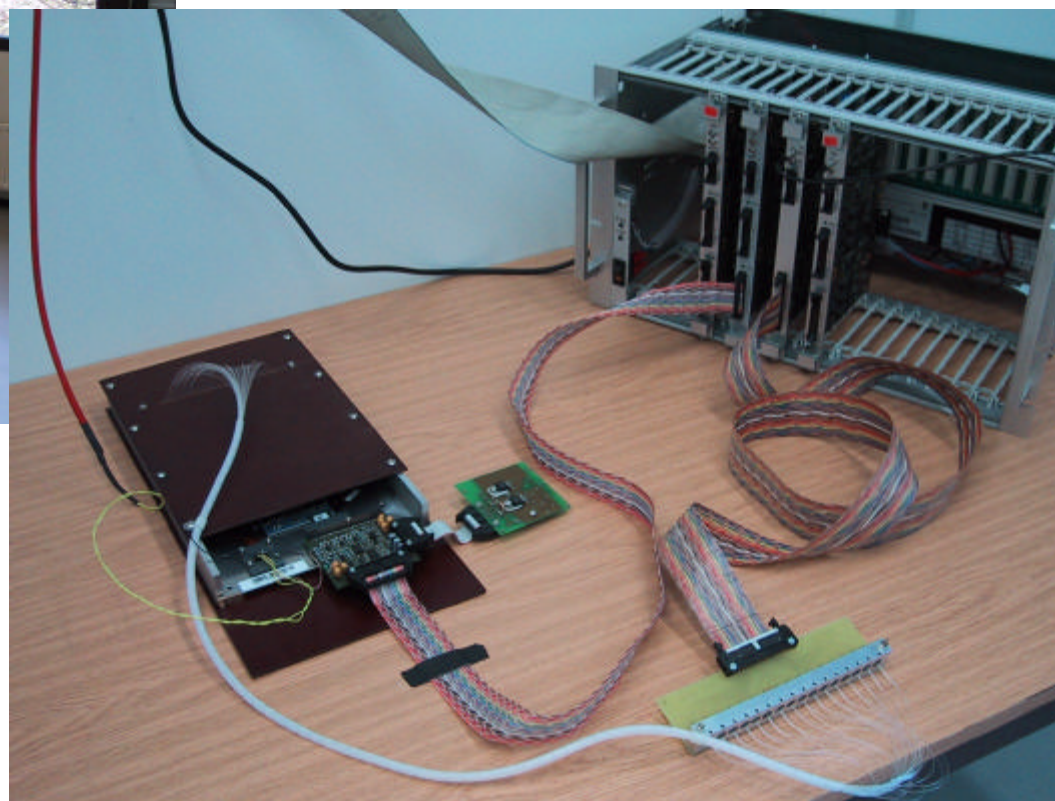
30216630200056





- Clean room used for module test and storage

- ARC Test Setup
- LED Pulser
- CAEN Sy126



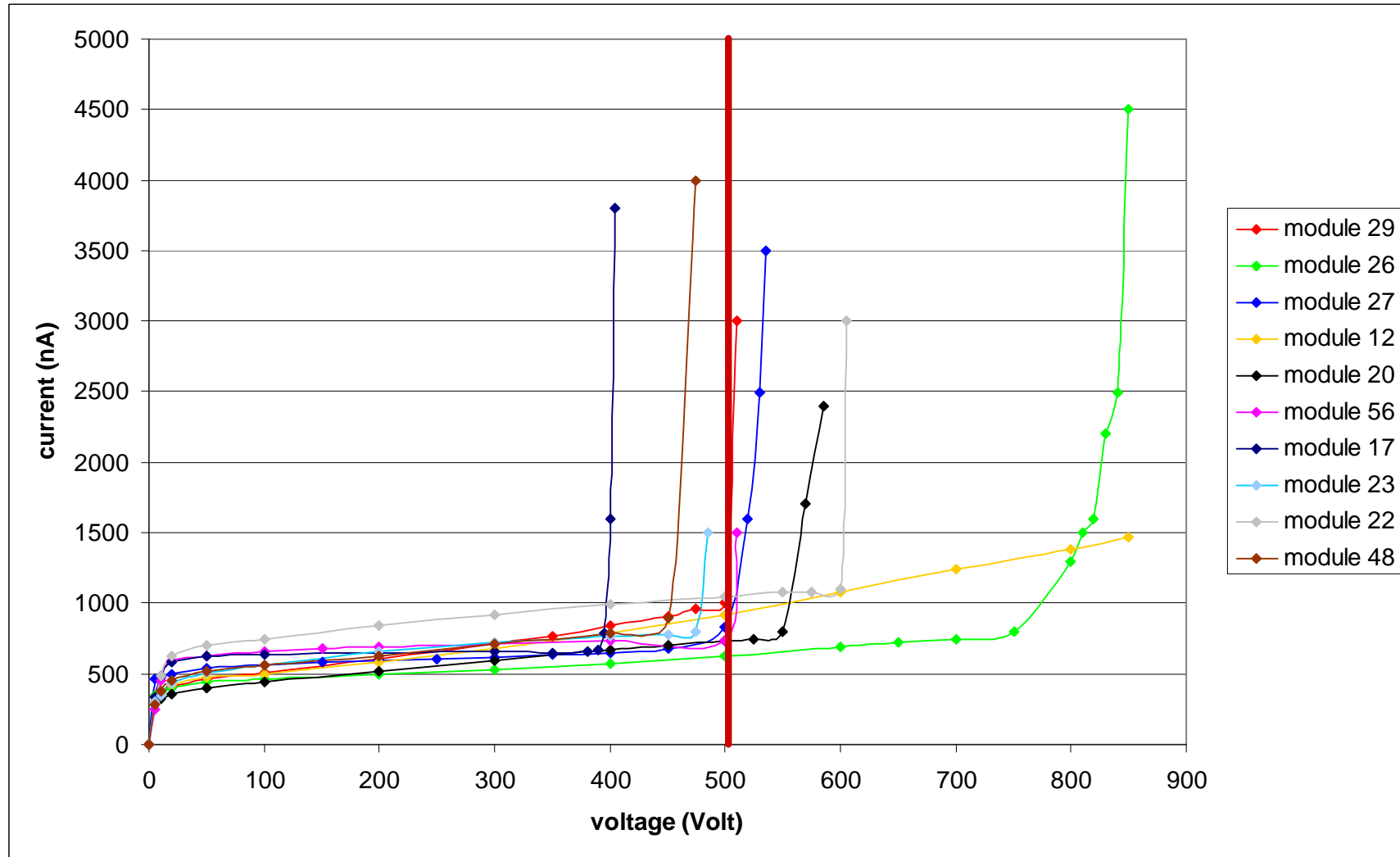


Performed Tests

- Tests based on proposals from L.Demaria & M.Meschini:
 - IV Curves
 - Basic Tests at 150 V:
 - H0-Tests
 - F-Tests
 - Psh-Tests
 - Advanced Tests at 150 V:
 - Pipe-Tests
 - L-Tests (pulsed light, 950 nm)
 - Laser-Tests (at 50 V, 1060 nm)



IV Curves

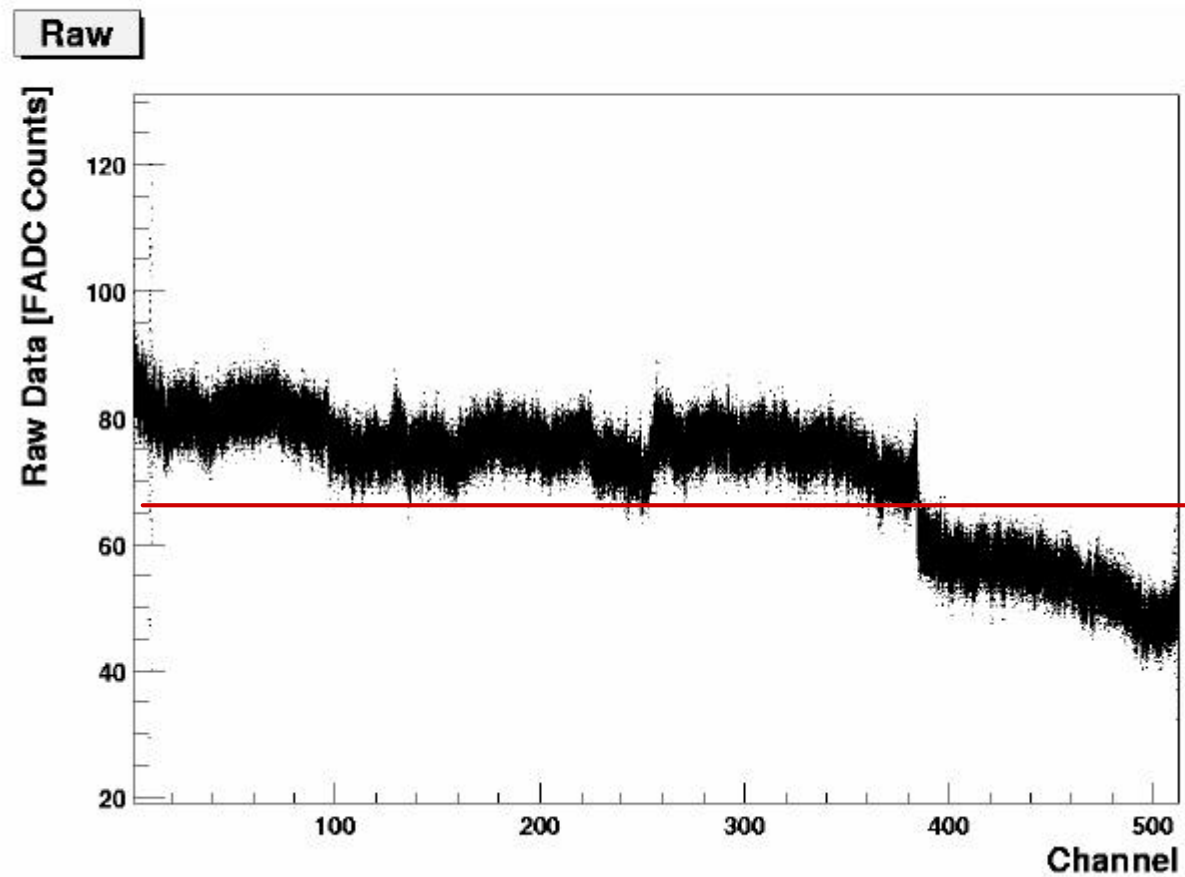


● Measurements done at room temperature with no N₂ flush !



Pedestals / Raw Data

- Different baselines at same APV settings !



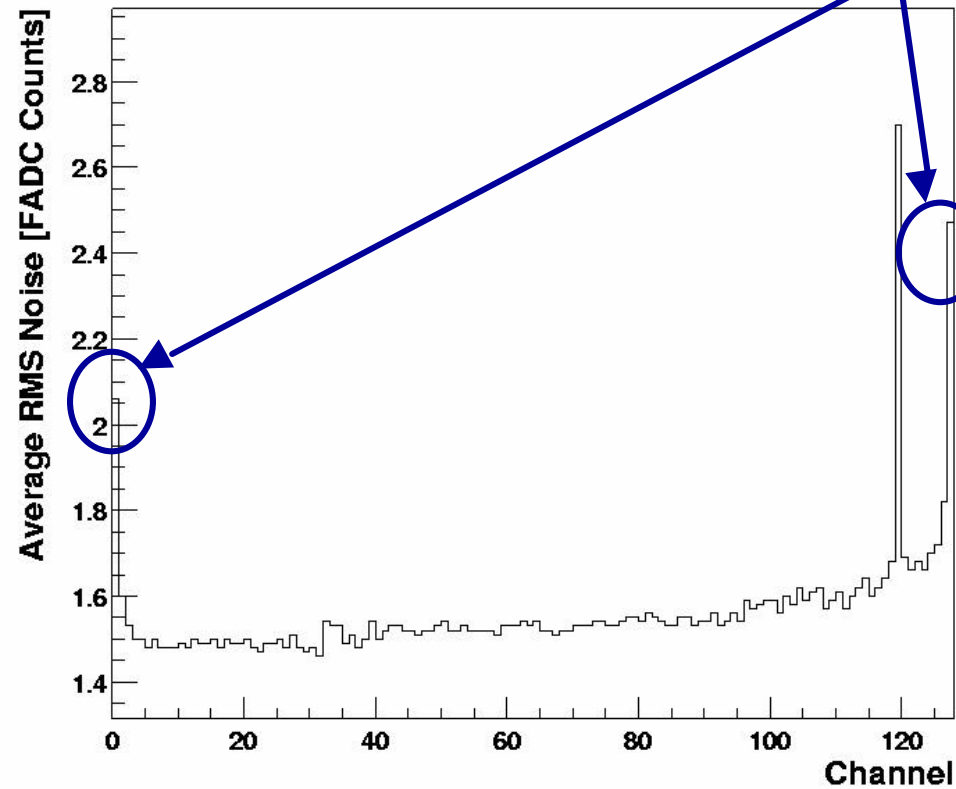


RMS Noise

Noise of channels on the edges is
often in the order of defect channels !

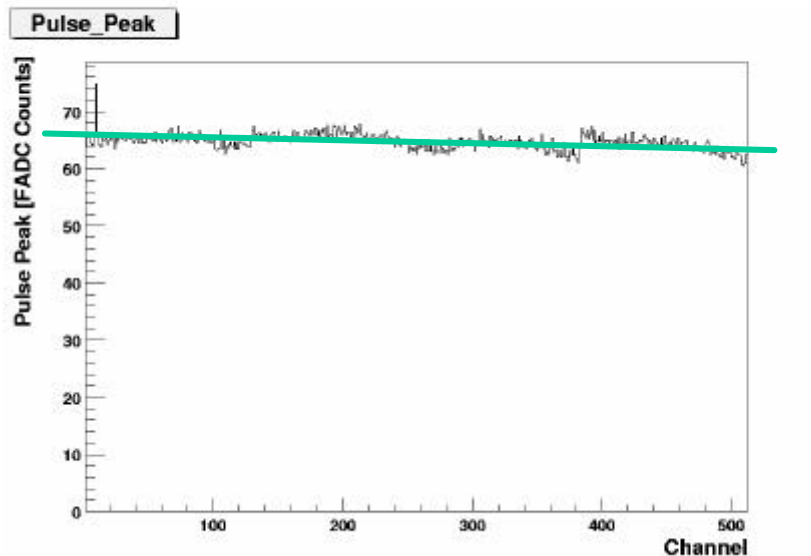
```
Chip Settings:  
I2C.Address= 74  
Mode= 43  
Latency= 4  
IPRE= 98  
IPCASC= 52  
IPSP= 34  
ISHA= 34  
ISSP= 34  
IPSP= 55  
IMUXIN= 34  
ISPARE= 0  
ICAL= 29  
VFP= 30  
VPS= 60  
VPSP= 40  
CDRV= 254  
CSEL= 1  
MUXGAIN= 4  
Error= 0  
-----  
Cut: 3*RMS  
Bad Channel:  
0  
119  
127
```

RMS Noise

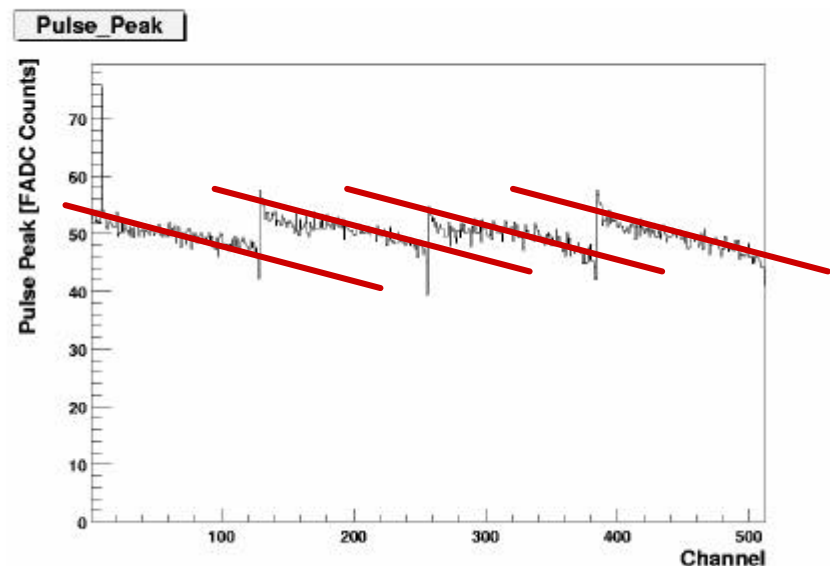




Calibration Pulse Shapes (Psh-Test at 150 V)



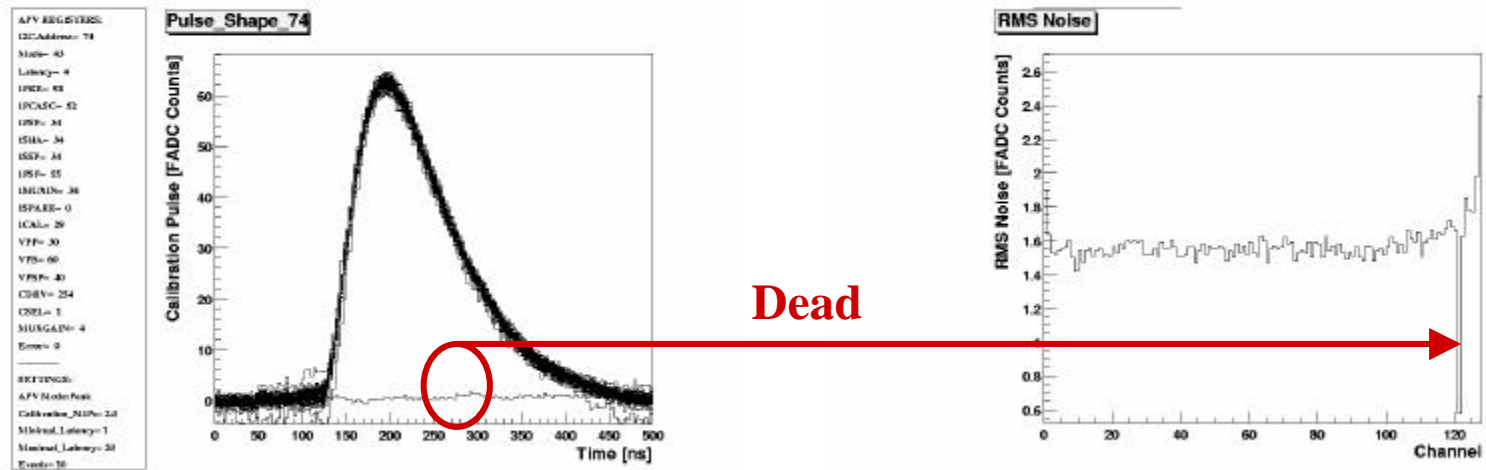
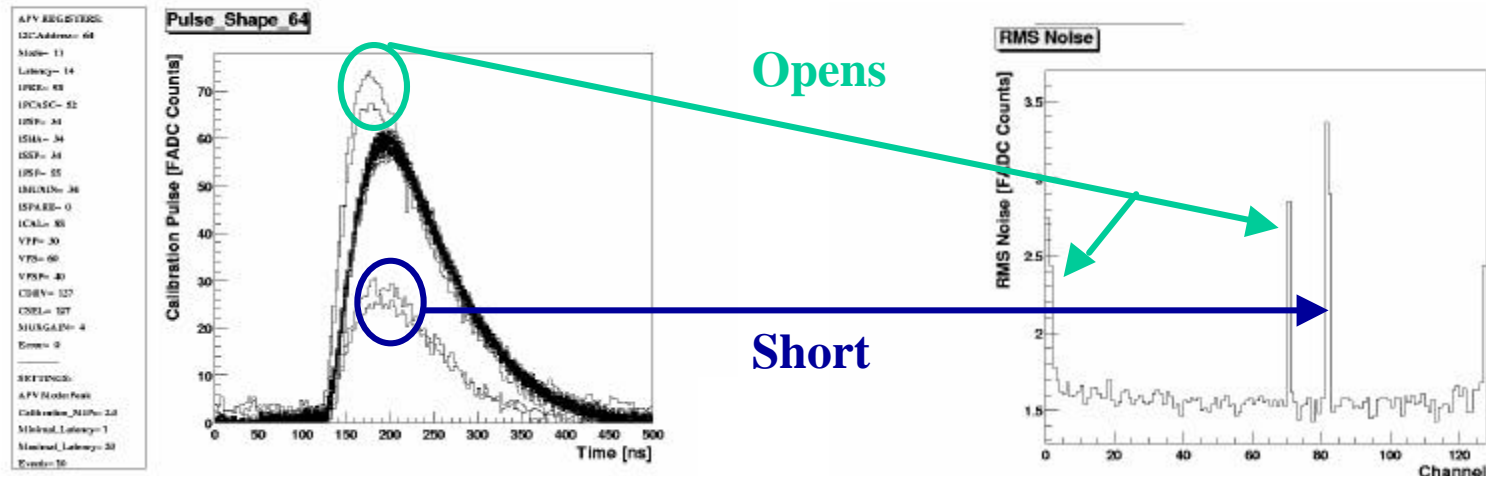
Pulse shape maxima
distribution in
peak mode



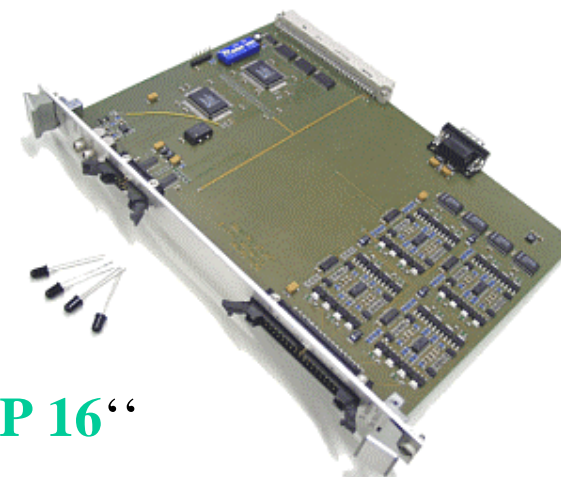
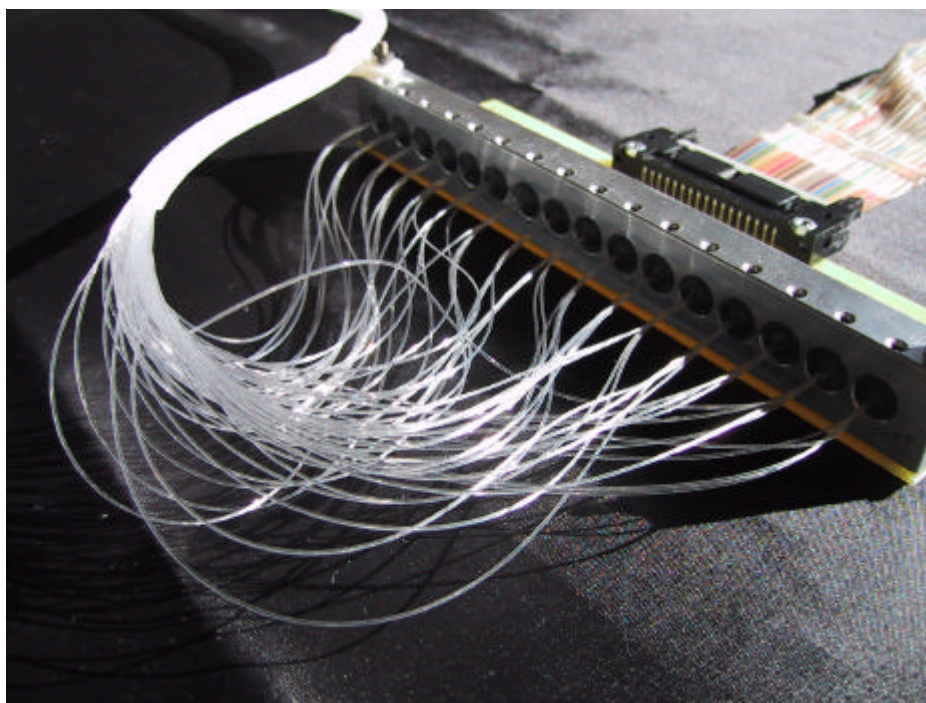
Pulse shape maxima
distribution in
deconvolution mode



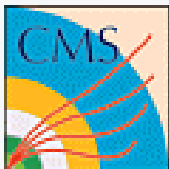
Calibration Pulse Shapes and RMS Noise



- 16 IR LEDs (950 nm)
- 4 fibres connected to 1 LED



“LEPP 16”

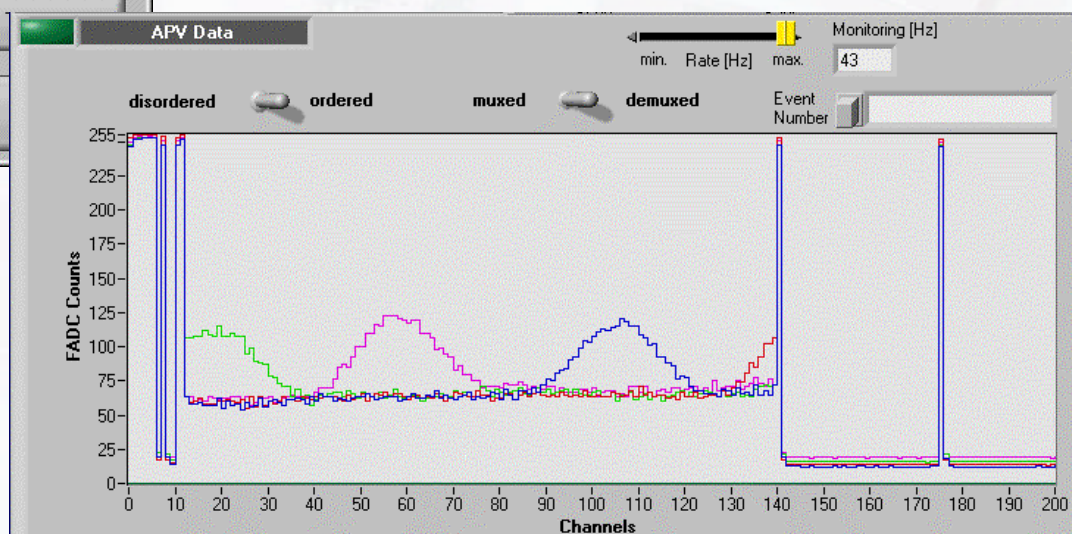


Automated „Running Light“



LED control window
(as implemented in ARCS)

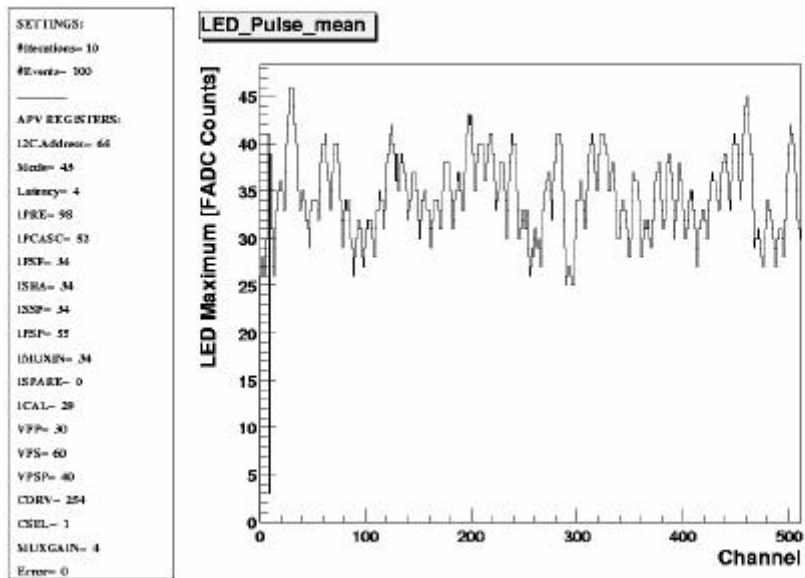
Online data display



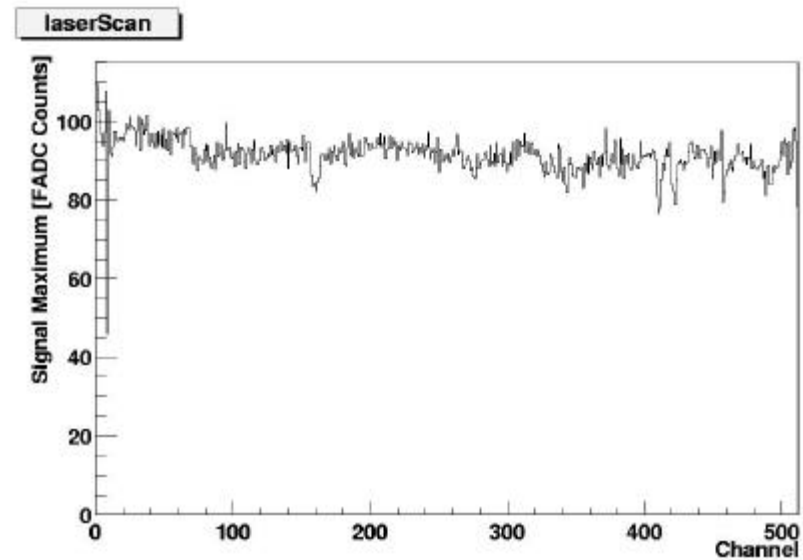


LED & Laser Tests

LED tests at 150 V, 950 nm



Laser tests at 50 V, 1050 nm





Preliminary Test Results

Module		T e s t s									R e s u l t s				
		IV	Basic			PSh	LED	Laser	Pipe	Bad strips	Grade: < 2% Grade A < 4% Grade B				
			HO F	Ped	Noise										
302166302000	12					512 511 442 431 430 257 256 209 129 1		511 442 431 430		511 442 431 430 209		10	B		
	17	X 400 V				512 443 442 384 257 256 129 93 92 1		443 442 93 92		443 442 93 92		10	B		
	20					512 511 385 384 258 257 256 129 1						9	A		
	22					512 511 385 384 257 256 129 1		318		318		8	A		
	23	X 480 V				512 511 385 384 258 257 256 129 1						9	A		
	26					512 480 385 384 258 257 256 129 128 1		480		480		480		10	B
	27					512 385 384 257 256 248 129 128 93 1		93 248		93 248		93 248		10	B
	29					512 385 384 257 256 189 129 7 1		7 189		7 189			9	A	
	48	X 450 V				512 385 384 257 256 129 128 9 1		9		9		9	9	A	
	56					512 511 385 384 257 256 129 128 1							9	A	

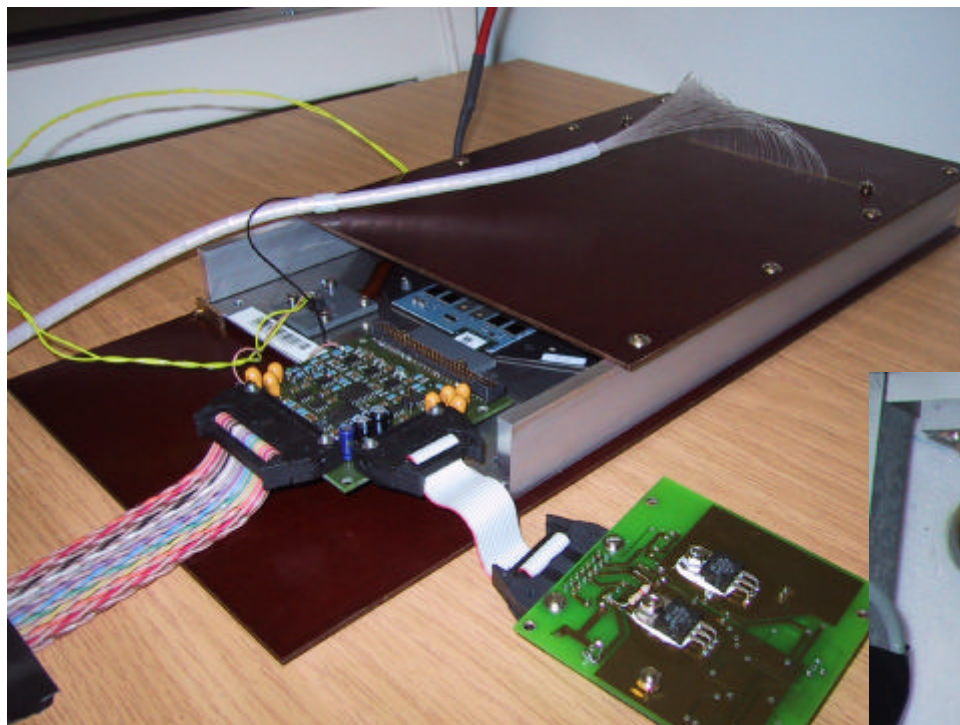


Outlook

- Investigation of LED tests
- Comparison of LED and laser results
- Cooling tests
- Detailed comparison of results of both test systems



Environment & Test Setup



- Cooling Tests
(with LED array)

- Cooling Box
(can house 5 modules)

